TOSHIBA Multi-Chip Device Silicon P-Channel MOS Type (U-MOS II) + N-Channel MOS Type (Planer)

SSM6E01TU

Load Switch Applications

- P-channel MOSFET and N-channel MOSFET incorporated into one package.
- Low power dissipation due to P-channel MOSFET that features low $R_{DS}\left(\text{ON}\right)$ and low-voltage operation

Q1 Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-Source voltage		V _{DS}	-12	V
Gate-Source voltage		V _{GSS}	±12	V
Drain current	DC	۱ _D	-1.0	А
	Pulse	I _{DP} (Note 2)	-2.0	~

Q2 Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-Source voltage		V _{DS}	20	V
Gate-Source voltage		V _{GSS}	10	V
Drain current	DC	I _D	0.05	А
	Pulse	I _{DP} (Note 2)	0.2	~

2.1±0.1 1.7±0.1 6 0.65 0.65 0.3+0.1/-0.05 2.0±0.1 .3±0.1 5 2 0.7±0.05 0.16 +0.06/-0.05 1: N-channel drain P-channel gate 2: N-channel gate 3: P-channel source 4: P-channel drain 5: P-channel drain 6: N-channel source UF6 JEDEC _ JEITA ____ TOSHIBA _

Weight: 7.0 mg (typ.)

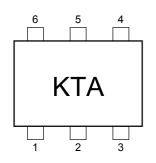
Maximum Ratings (Q1, Q2 common) (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Drain power dissipation	P _D (Note 1)	0.5	W
Channel temperature	T _{ch}	150	°C
Storage temperature range	T _{stg}	-55~150	°C

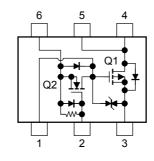
Note 1: Mounted on an FR4 board (25.4 mm × 25.4 mm × 1.6 t, Cu pad: 645 mm²)

Note 2: Pulse width limited by maximum channel temperature.

Marking



Equivalent Circuit (top view)



Unit: mm

Handling Precaution

This product has a MOS structure and is sensitive to electrostatic discharge. When handling individual devices (that have not yet been mounted on a PCB), ensure that the environment is protected against static electricity. Operators should wear anti-static clothing, containers and other objects which may come into direct contact with devices should be made of anti-static materials.

 $Thermal\ resistance\ R_{th}\ (j-a)\ and\ drain\ power\ dissipation\ P_D\ vary\ depending\ on\ board\ material,\ board\ area,\ board\ thickness\ and\ pad\ area.\ When\ using\ this\ device,\ please\ take\ heat\ dissipation\ into\ consideration.$

Q1 Electrical Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Forward voltage (diode)	V _{DSF}	$I_{DR} = 1.0 \text{ A}, V_{GS} = 0 \text{ V}$		_	1.2	V
Gate leakage current	I _{GSS}	$V_{GS}=\pm 10~V,~V_{DS}=0$		_	±1	μA
Drain-Source breakdown voltage	V (BR) DSS	$I_D = -1 \text{ mA}, V_{GS} = 0$	-12	_	_	V
Drain cut-off current	I _{DSS}	$V_{DS} = -12 \text{ V}, \text{ V}_{GS} = 0$		_	-1	μA
Gate threshold voltage	V _{th}	$V_{DS} = -3 \text{ V}, \text{ I}_{D} = -0.1 \text{ mA}$	-0.4	_	-1.1	V
Forward transfer admittance	Y _{fs}	$V_{DS} = -3 V, I_D = -0.5 A$ (Note 3)	1.3	2.5		S
Drain-Source ON resistance	D- a varu	$I_D = -0.5 \text{ A}, V_{GS} = -4 \text{ V}$ (Note 3)		125	160	mΩ
	R _{DS (ON)}	$I_D = -0.5 \text{ A}, V_{GS} = -2.5 \text{ V}$ (Note 3)		180	240	1115.2
Input capacitance	C _{iss}	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$		310	_	pF

Note 3: Pulse test

Q2 Electrical Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I _{GSS}	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 0$	_		15	μA
Drain-Source breakdown voltage	V (BR) DSS	$I_D = 0.1 \text{ mA}, V_{GS} = 0$	20	_	_	V
Drain cut-off current	I _{DSS}	$V_{DS} = 20 V, V_{GS} = 0$	_	_	1	μA
Gate threshold voltage	V _{th}	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 0.1 \text{ mA}$	0.7	_	1.3	V
Forward transfer admittance	Y _{fs}	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 10 \text{ mA}$ (Note 3)	25	50	_	mS
Drain-Source ON resistance	R _{DS (ON)}	$I_D = 10 \text{ mA}, V_{GS} = 2.5 \text{ V}$ (Note 3)	_	4	10	Ω
Input capacitance	C _{iss}	$V_{DS} = 3 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$	_	11	_	pF
Gate-Source resistance	R _{GS}	V _{GS} = 0~10 V	0.7	1.0	1.3	MΩ

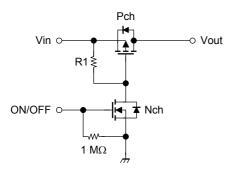
Note 3: Pulse test

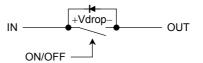
Precaution

 V_{th} can be expressed as voltage between gate and source when low operating current value is I_D = $\pm 100~\mu A$ for this product. For normal switching operation, V_{GS} (_on) requires higher voltage than V_{th} and V_{GS} (_off) requires lower voltage than V_{th} . (Relationship can be established as follows: V_{GS} (_off) < V_{th} < V_{GS} (_on))

Please take this into consideration for using the device. 2.5 V or higher is recommended for VGS voltage to turn on the N-channel MOSFET of this product.

Load Switch Application





Load Switch Ratings (Ta = 25°C)

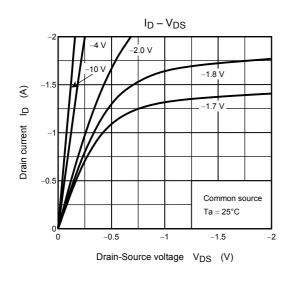
Characteristics	Symbol	Rating	Unit
Input voltage	V _{in}	2.5~12	V
ON/OFF voltage	V _{on/off}	2.5~10	V
Load current (DC)	١L	1	А
Load current (pulse)	I _{LP} (Note 4)	2	А
Channel temperature	T _{ch}	150	°C

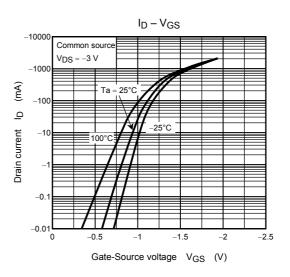
Note 4: Pulse width limited by maximum channel temperature.

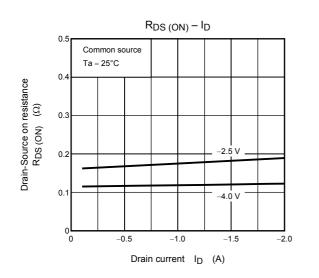
Load Switch Electrical Characteristics (Ta = 25°C)

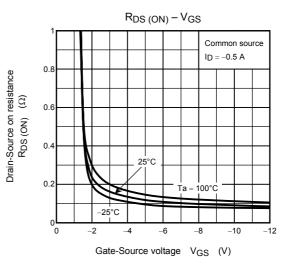
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Leakage current	I _{FL}	$V_{in} = 8 V, V_{ON/OFF} = 0$			1	μA
P-channel drop voltage	V _{DROP} (1)	$V_{in} = 3.0 \text{ V}, \text{ V}_{ON/OFF} = 2.5 \text{ V}, \ I_L = 0.5 \text{ A}$	_	0.09	0.12	v
	V _{DROP (2)}	$V_{in} = 5.0 \text{ V}, V_{ON/OFF} = 2.5 \text{ V}, I_L = 1.0 \text{ A}$	_	0.13	0.16	
N-channel drive voltage	V _{on/off}	$V_{DS} = 3 V, I_D = 0.1 mA$	0.7	_	1.3	V

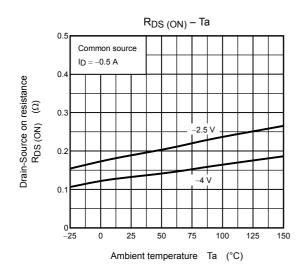
Q1 (Pch MOSFET)

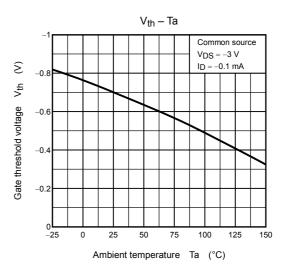




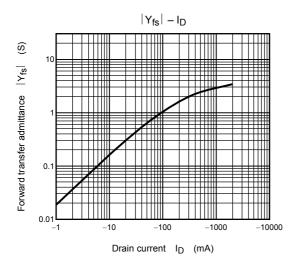


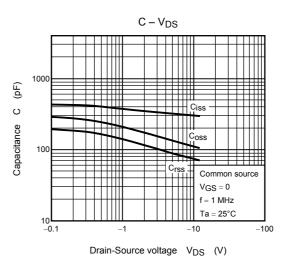


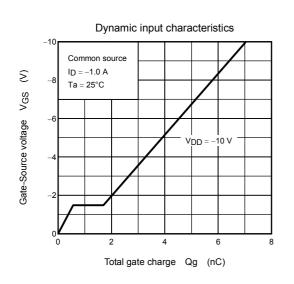


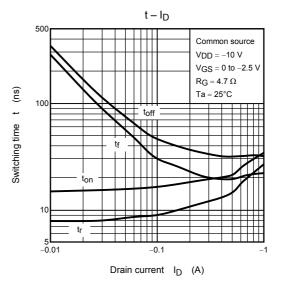


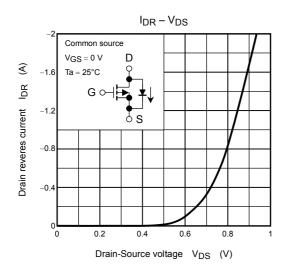
Q1 (Pch MOSFET)



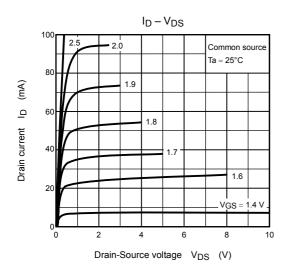


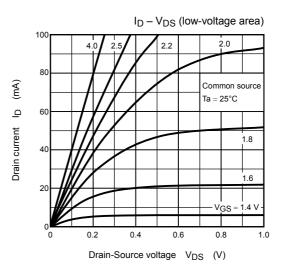


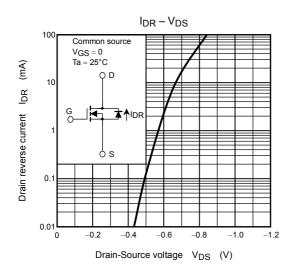


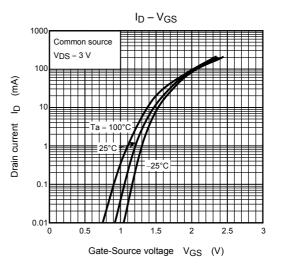


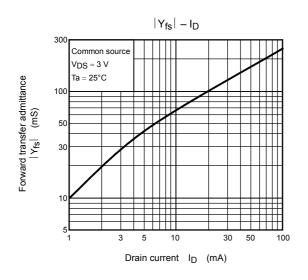
Q2 (Nch MOSFET)

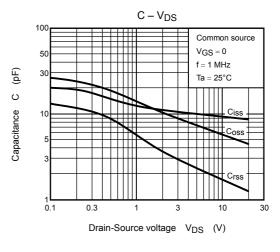




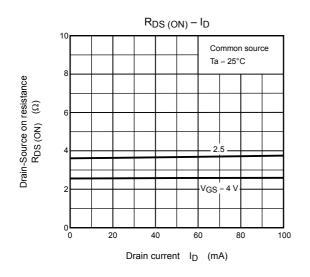


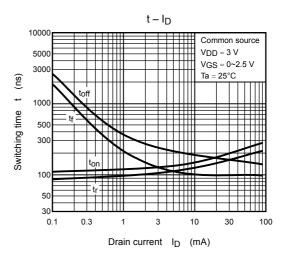


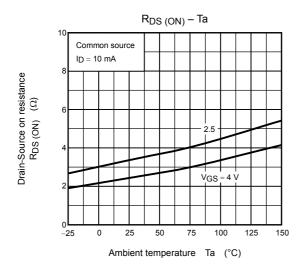




Q2 (Nch MOSFET)







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